

Application/Control No.	Applicant(s)/Patent under Reexamination
10/520,103	DAMITZ ET AL.
Examiner	Art Unit
HIEU T. VO	3747

	SEAR	CHED	
Class	Subclass	Date	Examiner
701	111 102 110 115	6/25/2007	VH
73	118.1	6/25/2007	VH
		·	
	-		
			,

. INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	· ·				
All of	above	6/25/2007	- VH		

(INCLUDING SEARCH	ISTRATEGY)
	DATE	EXMR
EAST	6/25/2007	VH
PLUS	4/25/2007	VH
· · ·		